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<b>Information Disclosure Statement By Applicant</b>	<b>Applicants: Matthew P. KULIG, et al.</b>
	<b>Art Unit: 2457</b>
	<b>Confirmation No.: 6376</b>
(Use Several Sheets if Necessary)	<b>Filing Date: October 19, 2001</b>

**U.S. Patent Documents**

Examiner Initials	No.	Patent No.	Issue Date	Patentee	Priority Date
OT	5,404,411	4/4/1995	Banton, et al.	12/27/1990	
OU	5,463,701	10/31/1995	Kanther, et al.	10/20/1992	
OV	5,687,297	11/11/1997	Coonan, et al.	6/29/1995	
OVW	5,886,701	3/23/1999	Chauvin, et al.	8/4/1995	
OX	6,124,844	9/26/2000	Ilbery	1/5/1996	

**Published U.S. Patent Application**


**Foreign Patent or Published Foreign Patent Application**

Examiner Initials	No.	Document No.	Publication Date	Applicant

**Non-Patent Literature Documents**

Examiner Initials	No.	Author, Title, Date, Place (e.g. Journal) of Publication
OY		Fernandez, X.; "TEMPLATE MATCHING OF BINARY TARGETS IN GREY-SCALE IMAGES: A NONPARAMETRIC APPROACH"; Pattern Recognition, Vol. 30, No. 7, pp. 1175-1182, 1997, Great Britain.

Examiner's Signature: /Barbara Burgess/

Date: 12/29/2009

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.